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# FDT458P

# 30V P-Channel PowerTrench® MOSFET

### **General Description**

This P-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers, and battery chargers.

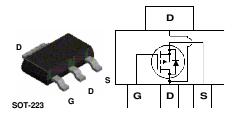
These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable  $R_{\text{DS(ON)}}$  specifications.

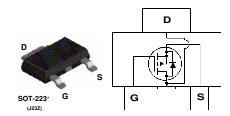
### **Applications**

- · Battery chargers
- Motor drives

#### **Features**

- 3.4 A, -30 V.  $R_{DS(ON)} = 130 \text{ m}\Omega$  @  $V_{GS} = 10 \text{ V}$   $R_{DS(ON)} = 200 \text{ m}\Omega$  @  $V_{GS} = 4.5 \text{ V}$
- · Fast switching speed
- Low gate charge (2.5 nC typical)
- High performance trench technology for extremely low R<sub>DS(ON)</sub>
- High power and current handling capability in a widely used surface mount package





# Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage		- 30	V
V <sub>GSS</sub>	Gate-Source Voltage		±20	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	3.4	Α
	- Pulsed		10	
PD	Maximum Power Dissipation	(Note 1a)	3.0	W
		(Note 1b)	1.3	
		(Note 1c)	1.1	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temper	ature Range	−55 to +150	°C

# **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	42	°C/W
R <sub>0</sub> JC	Thermal Resistance, Junction-to-Case	(Note 1)	12	°C/W

**Package Marking and Ordering Information** 

	<u> </u>	<u> </u>			
Device Marking	Device	Reel Size	Tape width	Quantity	
458P	FDT458P	13"	12mm	2500 units	

Electrical Characteristics T <sub>A</sub> = 25°C unless otherwise noted							
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units	
Off Char	acteristics			•		•	
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-30			V	
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu A$ , Referenced to 25°C		-23		mV/°C	
DSS	Zero Gate Voltage Drain Current	$V_{DS} = -24 \text{ V},  V_{GS} = 0 \text{ V}$			-1	μΑ	
GSSF	Gate-Body Leakage, Forward	$V_{GS} = -25 \text{ V},  V_{DS} = 0 \text{ V}$			100	nA	
I <sub>GSSR</sub>	Gate-Body Leakage, Reverse	$V_{GS} = -25 \text{ V},  V_{DS} = 0 \text{ V}$			-100	nA	
On Char	acteristics (Note 2)						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-1	-1.8	-3	V	
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \mu A$ , Referenced to 25°C		4		mV/°C	
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$\begin{split} V_{GS} &= -10 \text{ V}, & l_D = -3.4 \text{ A} \\ V_{GS} &= -4.5 \text{ V}, & l_D = -2.7 \text{ A} \\ V_{GS} &= -10 \text{ V}, l_D = -3.4 \text{ A}, T_J = 125^{\circ}\text{C} \end{split}$		105 157 147	130 200 210	mΩ	
$I_{D(on)}$	On-State Drain Current	$V_{GS} = -10 \text{ V}, \qquad V_{DS} = -5 \text{ V}$	<b>-</b> 5			Α	
<b>g</b> FS	Forward Transconductance	$V_{DS} = -5 \text{ V}, \qquad I_{D} = -3.4 \text{ A}$		3		S	
Dynamic	Characteristics			•		•	
Ciss	Input Capacitance	$V_{DS} = -15 \text{ V},  V_{GS} = 0 \text{ V},$		205		pF	
Coss	Output Capacitance	f = 1.0 MHz		55		pF	
C <sub>rss</sub>	Reverse Transfer Capacitance			26		pF	
Switchin	g Characteristics (Note 2)			•			
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = -15 \text{ V}, \qquad I_D = -1 \text{ A}, \\ V_{GS} = -10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		4.5	9	ns	
t <sub>r</sub>	Turn-On Rise Time			12.5	23	ns	
t <sub>d(off)</sub>	Turn-Off Delay Time			11	20	ns	
t <sub>f</sub>	Turn-Off Fall Time			2	4	ns	
Qg	Total Gate Charge	$V_{DS} = -15 \text{ V}, \qquad I_D = -3.4 \text{ A},$		2.5	3.5	nC	
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = -10 \text{ V}$		0.7		nC	
$Q_{gd}$	Gate-Drain Charge	]		1		nC	
Drain-So	ource Diode Characteristics	and Maximum Ratings		•	•	•	
ls	laximum Continuous Drain–Source Diode Forward Current				-2.5	Α	
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V},  I_S = -2.5 \text{ A}  \text{(Note 2)}$		-0.8	-1.2	V	

#### Notes

R<sub>BJA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>BJC</sub> is guaranteed by design while R<sub>BCA</sub> is determined by the user's board design.



a) 42°C/W when mounted on a 1ir² pad of 2 oz copper



b) 95°C/W when mounted on a .0066 in² pad of 2 oz copper



c) 110°C/W when mounted on a minimum pad.

<sup>2.</sup> Pulse Test: Pulse Width  $< 300 \mu s$ , Duty Cycle < 2.0%

# **Typical Characteristics**

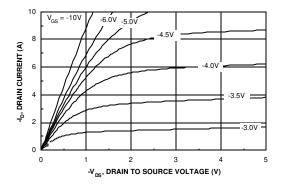


Figure 1. On-Region Characteristics.

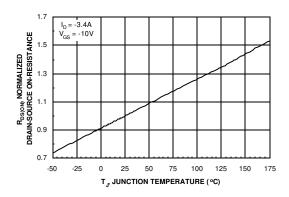


Figure 3. On-Resistance Variation with Temperature.

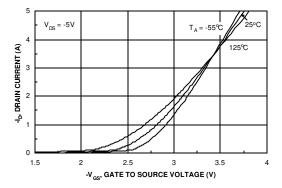


Figure 5. Transfer Characteristics.

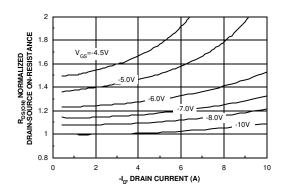


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

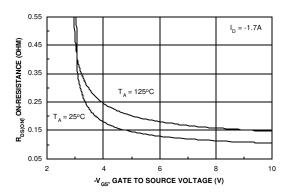


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

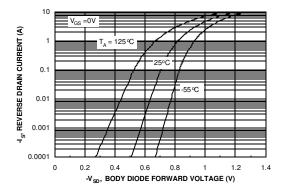
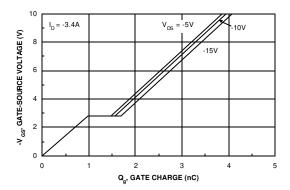


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

# **Typical Characteristics**



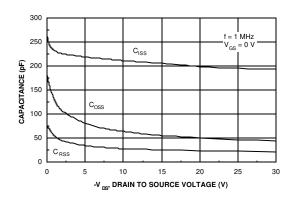
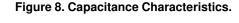
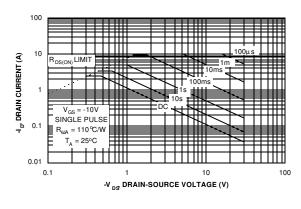


Figure 7. Gate Charge Characteristics.





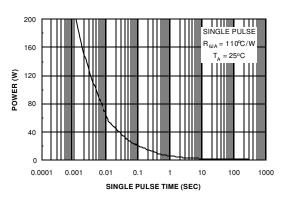


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

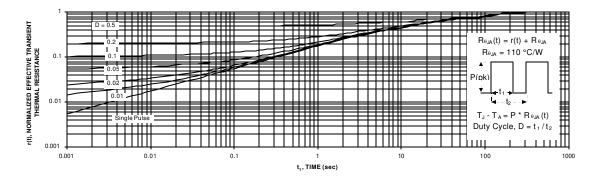
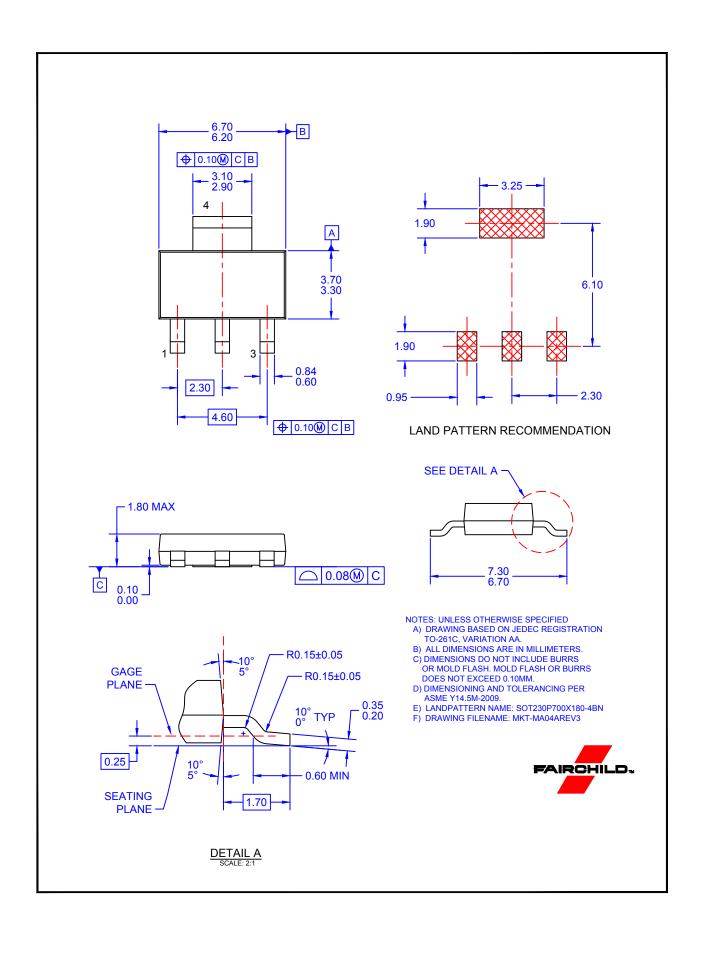


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.



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